TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TC74ACT257P, TC74ACT257F, TC74ACT257FN

2 - CHANNEL MULTIPLEXER (3 - STATE)

The TC74ACT257 is an advanced high speed CMOS MULTIPLEXER fabricated with silicon gate and double-layer metal wiring C^2MOS technology.

It achieve the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

This device may be used as a level converter for interfacing TTL or NMOS to High Speed CMOS. The inputs are compatible with TTL or NMOS and CMOS output voltage levels.

Each is composed of four independent 2-channel multiplexers with common SELECT and \overline{OUTPUT} ENABLE (\overline{OE}).

If \overline{OE} is set low, the outputs are held in a high-impedance state. When SELECT is set low, "A" data inputs are enabled. Conversely, when SELECT is high, "B" data inputs are enabled.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

FEATURES:

- High Speed-----t_{pd} = 5.8ns(typ.) at V_{CC} = 5V
- Compatible with TTL outputs... $V_{IL} = 0.8V$ (Max.)

 $V_{IH} = 2.0V (Min.)$

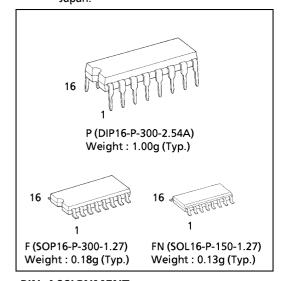
• Symmetrical Output Impedance | I_{OH} | = I_{OL} = 24mA(Min.)

Capability of driving 50Ω tansmission lines.

1

- Balanced Propagation Delays ····· t_{oLH} ≃ t_{oHL}
- Pin and Function Compatible with 74F257

(Note) The JEDEC SOP (FN) is not available in Japan.



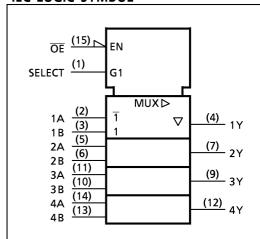
PIN ASSIGNMENT 16 V_{CC} SELECT 1 ŌĒ 15 1A 2 1B 3 14 4A 13 4B 12 4Y 2A 5 11 2B 6 3A 3B 2Y 7 10 GND 8 9 **3Y** (TOP VIEW)

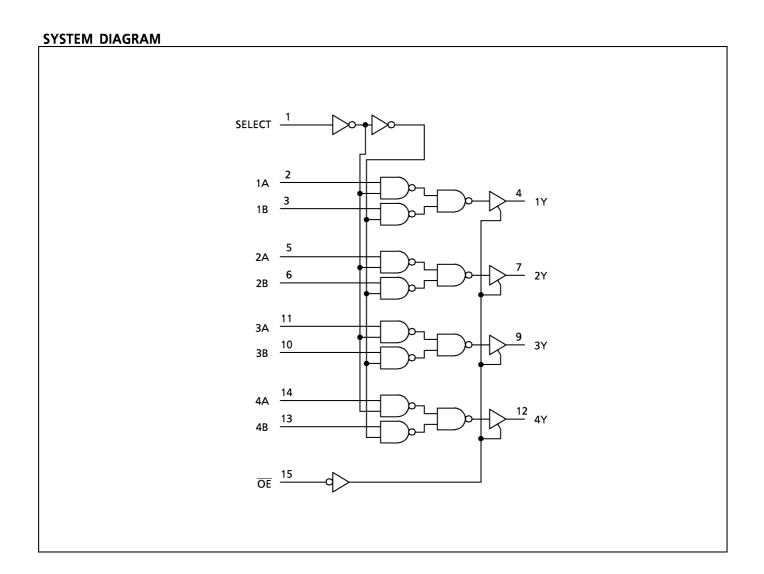
TRUTH TABLE

	INPU	OUTPUTS		
ŌĒ	SELECT	Α	В	Υ
Н	Х	Χ	Х	Z
L	L	L	Х	L
L	L	Н	Х	Н
L	Н	Χ	L	L
L	Н	Х	Τ	Н

X : Don't Care Z : High Impedance

IEC LOGIC SYMBOL





ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	V _{cc}	-0.5~7.0	V
DC Input Voltage	V _{IN}	$-0.5 \sim V_{CC} + 0.5$	V
DC Output Voltage	V _{OUT}	−0.5~V _{CC} + 0.5	V
Input Diode Current	I _{IK}	± 20	mA
Output Diode Current	I _{OK}	± 50	mA
DC Output Current	I _{OUT}	± 50	mA
DC V _{CC} /Ground Current	I _{cc}	± 100	mA
Power Dissipation	P _D	500 (DIP)* / 180 (SOP)	mW
Storage Temperature	T _{stg}	−65~150	°C

^{*500}mW in the range of Ta = -40° C \sim 65°C. From Ta = 65°C to 85°C a derating factor of -10mW/°C should be applied up to 300mW.

RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	V_{CC}	4.5~5.5	V
Input Voltage	V _{IN}	0~V _{CC}	V
Output Voltage	V _{OUT}	0~V _{CC}	V
Operating Temperature	T _{opr}	−40~85	°C
Input Rise and Fall Time	dt/dV	0~10	ns / V

DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION		V _{cc}	Ta = 25°C		C	Ta = −40~85°C		UNIT
PARAIVIETER	STIVIBOL			(V)	MIN.	TYP.	MAX.	MIN.	MAX.	UNIT
High - Level Input Voltage	V _{IH}			4.5 \$ 5.5	2.0	-	_	2.0	_	<
Low - Level Input Voltage	VIL			4.5 \$ 5.5	ı	ı	0.8	_	0.8	٧
High - Level Output Voltage	V _{OH}	$V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OH} = -50 \mu A$ $I_{OH} = -24 m A$ $I_{OH} = -75 m A^*$	4.5 4.5 5.5	4.4 3.94 —	4.5 — —		4.4 3.80 3.85	_ _ _	<
Low - Level Output Voltage	V _{OL}	$V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OL} = 50 \mu A$ $I_{OL} = 24 m A$ $I_{OL} = 75 m A*$	4.5 4.5 5.5		0.0 — —	0.1 0.36 —	_ _ _	0.1 0.44 1.65	>
3 - State Output Off - State Current	l _{oz}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = V_{CC} \text{ or GND}$		5.5	1	1	± 0.5	_	± 5.0	
Input Leakage Current	I _{I N}	$V_{IN} = V_{CC}$ or GND		5.5	1	-	± 0.1	_	± 1.0	μ A
	I _{cc}	$V_{IN} = V_{CC}$ or GND		5.5	-	_	8.0	_	80.0	
Quiescent Supply Current	I _C	PER INPUT : V _{IN} = 3.4V OTHER INPUT : V _{CC} or GND		5.5	_	_	1.35	_	1.5	mA

^{* :} This spec indicates the capability of driving 50Ω transmission lines. One output should be tested at a time for a 10ms maximum duration.

AC ELECTRICAL CHARACTERISTICS (C_L = 50pF , R_L = 500 Ω , Input t_r = t_f = 3ns)

PARAMETER	SYMBOL	TEST CONDITION		Ta = 25°C			$Ta = -40 \sim 85^{\circ}C$		UNIT
FARAIVIETER	STIVIBOL		V _{CC} (V)	MIN.	TYP.	MAX.	MIN.	MAX.	UINIT
Propagation Delay Time (A, B-Y)	t _{pLH} t _{pHL}		5.0 ± 0.5	ı	6.5	9.6	1.0	11.0	
Propagation Delay Time (SELECT—Y)	t _{pLH} t _{pHL}		5.0 ± 0.5	I	7.8	11.4	1.0	13.0	ns
Output Enable Time	t _{pZL} t _{pZH}		5.0 ± 0.5	ı	6.3	9.6	1.0	11.0	
Output Disable Time	t _{pLZ} t _{pHZ}		5.0 ± 0.5	_	6.3	8.8	1.0	10.0	
Input Capacitance	C _{IN}			_	5	10	_	10	
Output Capacitance	C _{OUT}		·	_	10	_	_	_	pF
Power Dissipation Capacitance	C _{PD} (1)			_	57	_	_	_	

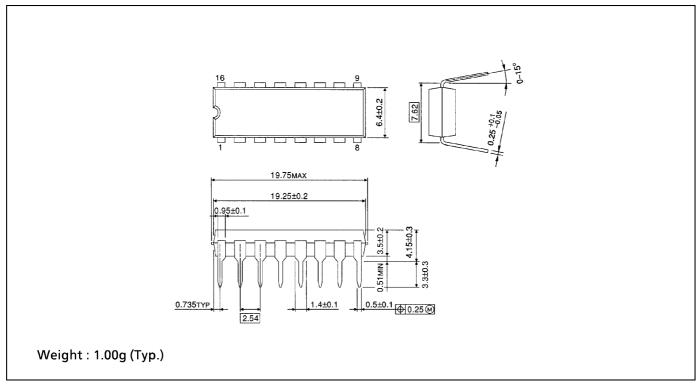
Note (1) C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 I_{CC} (opr.) = $C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC} / 4$ (per bit)

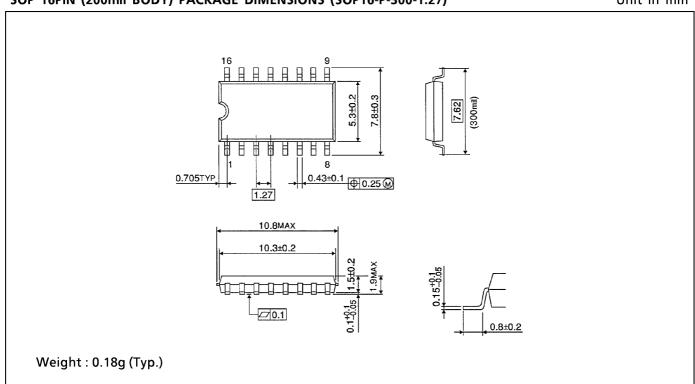
DIP 16PIN PACKAGE DIMENSIONS (DIP16-P-300-2.54A)

Unit in mm



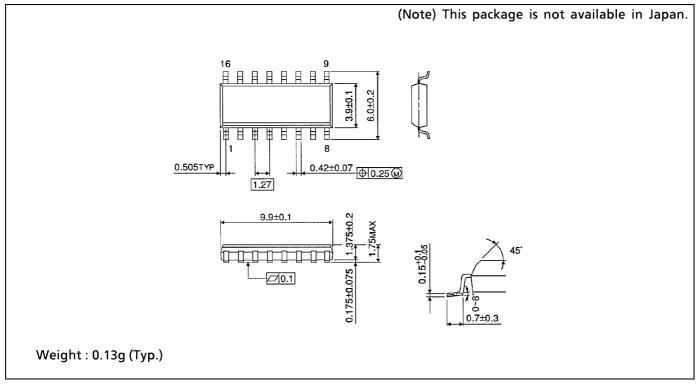
SOP 16PIN (200mil BODY) PACKAGE DIMENSIONS (SOP16-P-300-1.27)

Unit in mm



SOP 16PIN (150mil BODY) PACKAGE DIMENSIONS (SOL16-P-150 -1.27)

Unit in mm



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7

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